

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/641,308	LAROIA ET AL.	
Examiner	Art Unit	
VAIBHAV (MANU) SAWHNEY	2616	

	SEARCHED				
Class	Subclass	Date	Examiner		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	1				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
370/\$ + text	4/9/2007	V.S.	
455/\$ + text	4/9/2007	V.S.	
Kwang Yao - SPE	4/9/2007	V.S.	
inventor search	4/9/2007	V.S.	
assignee search	4/9/2007	V.S.	
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